

RF Power Field Effect Transistor

N-Channel Enhancement-Mode Lateral MOSFET

Designed for Class A or Class AB base station applications with frequencies up to 2000 MHz. Suitable for analog and digital modulation and multicarrier amplifier applications.

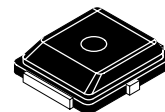
- Typical Two-Tone Performance @ 1960 MHz, 28 Volts, $I_{DQ} = 50$ mA,
 $P_{out} = 4$ Watts PEP
 Power Gain — 18 dB
 Drain Efficiency — 33%
 IMD — -34 dBc
- Typical Two-Tone Performance @ 900 MHz, 28 Volts, $I_{DQ} = 50$ mA,
 $P_{out} = 4$ Watts PEP
 Power Gain — 19 dB
 Drain Efficiency — 33%
 IMD — -39 dBc
- Capable of Handling 5:1 VSWR, @ 28 Vdc, 1960 MHz, 4 Watts CW Output Power

Features

- Characterized with Series Equivalent Large-Signal Impedance Parameters
- On-Chip RF Feedback for Broadband Stability
- Integrated ESD Protection
- RoHS Compliant
- In Tape and Reel. T1 Suffix = 1000 Units per 12 mm, 7 inch Reel.

MW6S004NT1

**1-2000 MHz, 4 W, 28 V
LATERAL N-CHANNEL
RF POWER MOSFET**



**CASE 466-03, STYLE 1
PLD 1.5
PLASTIC**

Table 1. Maximum Ratings

| Rating | Symbol | Value | Unit |
|--------------------------------|-----------|-------------|------|
| Drain-Source Voltage | V_{DSS} | -0.5, +68 | Vdc |
| Gate-Source Voltage | V_{GS} | -0.5, +12 | Vdc |
| Storage Temperature Range | T_{stg} | -65 to +150 | °C |
| Operating Junction Temperature | T_J | 150 | °C |

Table 2. Thermal Characteristics

| Characteristic | Symbol | Value (1,2) | Unit |
|---|-----------------|-------------|------|
| Thermal Resistance, Junction to Case Case Temperature 76°C, 4 W PEP, Two-Tone Case Temperature 79°C, 4 W CW | $R_{\theta JC}$ | 8.8 8.5 | °C/W |

Table 3. ESD Protection Characteristics

| Test Methodology | Class |
|---------------------------------------|--------------|
| Human Body Model (per JESD22-A114) | 1C (Minimum) |
| Machine Model (per EIA/JESD22-A115) | A (Minimum) |
| Charge Device Model (per JESD22-C101) | IV (Minimum) |

1. MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
2. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

Table 4. Moisture Sensitivity Level

| Test Methodology | Rating | Package Peak Temperature | Unit |
|---------------------------------------|--------|--------------------------|------|
| Per JESD 22-A113, IPC/JEDEC J-STD-020 | 3 | 260 | °C |

Table 5. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|----------------|--------|-----|-----|-----|------|
|----------------|--------|-----|-----|-----|------|

Off Characteristics

| | | | | | |
|---|-----------|---|---|-----|-----------------|
| Zero Gate Voltage Drain Leakage Current ($V_{DS} = 68\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$) | I_{DSS} | — | — | 10 | μAdc |
| Zero Gate Voltage Drain Leakage Current ($V_{DS} = 28\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$) | I_{DSS} | — | — | 10 | μAdc |
| Gate-Source Leakage Current ($V_{GS} = 5\text{ Vdc}$, $V_{DS} = 0\text{ Vdc}$) | I_{GSS} | — | — | 500 | nAdc |

On Characteristics

| | | | | | |
|---|--------------|-----|------|------|-----|
| Gate Threshold Voltage ($V_{DS} = 10\text{ Vdc}$, $I_D = 50\text{ mAdc}$) | $V_{GS(th)}$ | 1.2 | 2 | 2.7 | Vdc |
| Gate Quiescent Voltage ($V_{DS} = 28\text{ Vdc}$, $I_D = 50\text{ mAdc}$) | $V_{GS(Q)}$ | — | 2.7 | — | Vdc |
| Fixture Gate Quiescent Voltage ⁽¹⁾ ($V_{DD} = 28\text{ Vdc}$, $I_D = 50\text{ mAdc}$, Measured in Functional Test) | $V_{GG(Q)}$ | 2.2 | 3 | 4.2 | Vdc |
| Drain-Source On-Voltage ($V_{GS} = 10\text{ Vdc}$, $I_D = 50\text{ mAdc}$) | $V_{DS(on)}$ | — | 0.27 | 0.37 | Vdc |

Dynamic Characteristics

| | | | | | |
|---|-----------|---|----|---|----|
| Reverse Transfer Capacitance ($V_{DS} = 28\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$) | C_{rss} | — | 21 | — | pF |
| Output Capacitance ($V_{DS} = 28\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$) | C_{oss} | — | 25 | — | pF |
| Input Capacitance ($V_{DS} = 28\text{ Vdc}$, $V_{GS} = 0\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz) | C_{iss} | — | 30 | — | pF |

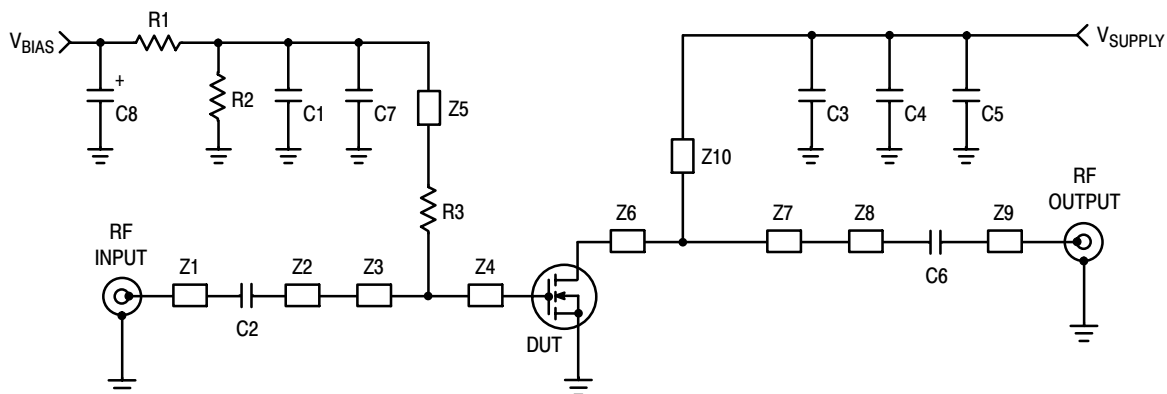
Functional Tests (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ} = 50\text{ mA}$, $P_{out} = 4\text{ W PEP}$, $f_1 = 1960\text{ MHz}$, $f_2 = 1960.1\text{ MHz}$, Two-Tone Test

| | | | | | |
|----------------------------|----------|------|-----|-----|-----|
| Power Gain | G_{ps} | 16.5 | 18 | 20 | dB |
| Drain Efficiency | η_D | 28 | 33 | — | % |
| Intermodulation Distortion | IMD | — | -34 | -28 | dBc |
| Input Return Loss | IRL | — | -12 | -10 | dB |

Typical Performance (In Freescale 900 MHz Demo Board, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ} = 50\text{ mA}$, $P_{out} = 4\text{ W PEP}$, $f = 900\text{ MHz}$, Two-Tone Test, 100 kHz Tone Spacing

| | | | | | |
|----------------------------|----------|---|-----|---|-----|
| Power Gain | G_{ps} | — | 19 | — | dB |
| Drain Efficiency | η_D | — | 33 | — | % |
| Intermodulation Distortion | IMD | — | -39 | — | dBc |
| Input Return Loss | IRL | — | -12 | — | dB |

1. $V_{GG} = \frac{11}{10} \times V_{GS(Q)}$. Parameter measured on Freescale Test Fixture, due to resistive divider network on the board. Refer to Test Circuit Schematic.



| | | | |
|----|----------------------------|-----|---|
| Z1 | 0.054" x 0.430" Microstrip | Z7 | 0.210" x 1.220" Microstrip |
| Z2 | 0.054" x 0.137" Microstrip | Z8 | 0.054" x 0.680" Microstrip |
| Z3 | 0.580" x 0.420" Microstrip | Z9 | 0.054" x 0.260" Microstrip |
| Z4 | 0.580" x 0.100" Microstrip | Z10 | 0.025" x 0.930" Microstrip |
| Z5 | 0.025" x 0.680" Microstrip | PCB | Arlon CuClad 250GX-0300-55-22, 0.020", $\epsilon_r = 2.5$ |
| Z6 | 0.210" x 0.100" Microstrip | | |

Figure 1. MW6S004NT1 Test Circuit Schematic

Table 6. MW6S004NT1 Test Circuit Component Designations and Values

| Part | Description | Part Number | Manufacturer |
|----------------|--|--------------------|--------------|
| C1 | 100 nF Chip Capacitor | CDR33BX104AKYS | Kemet |
| C2, C3, C6, C7 | 9.1 pF Chip Capacitors | ATC100B9R1CT500XT | ATC |
| C4, C5 | 10 μ F, 50 V Chip Capacitors | GRM55DR61H106KA88B | Murata |
| C8 | 10 μ F, 35 V Tantalum Chip Capacitor | T490D106K035AT | Kemet |
| R1 | 1 k Ω , 1/4 W Chip Resistor | CRCW12061001FKEA | Vishay |
| R2 | 10 k Ω , 1/4 W Chip Resistor | CRCW12061002FKEA | Vishay |
| R3 | 10 Ω , 1/4 W Chip Resistor | CRCW120610R0FKEA | Vishay |

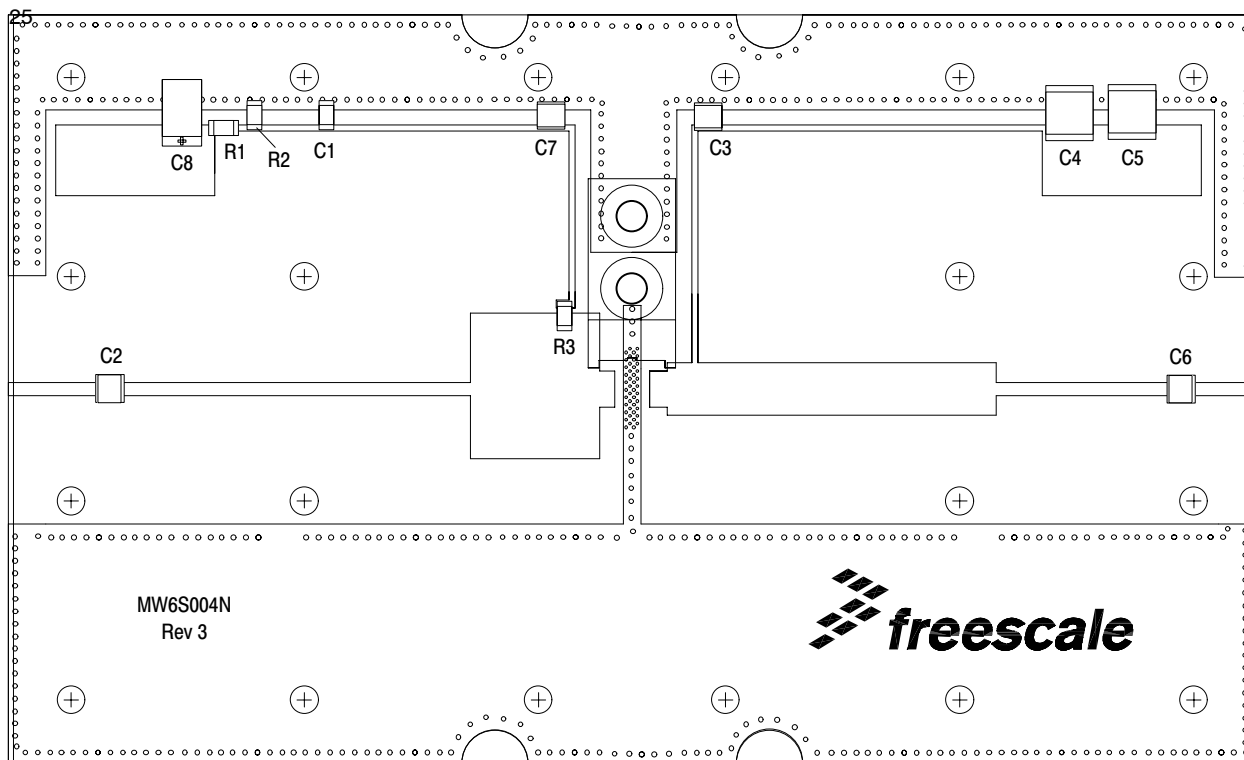


Figure 2. MW6S004NT1 Test Circuit Component Layout

TYPICAL CHARACTERISTICS

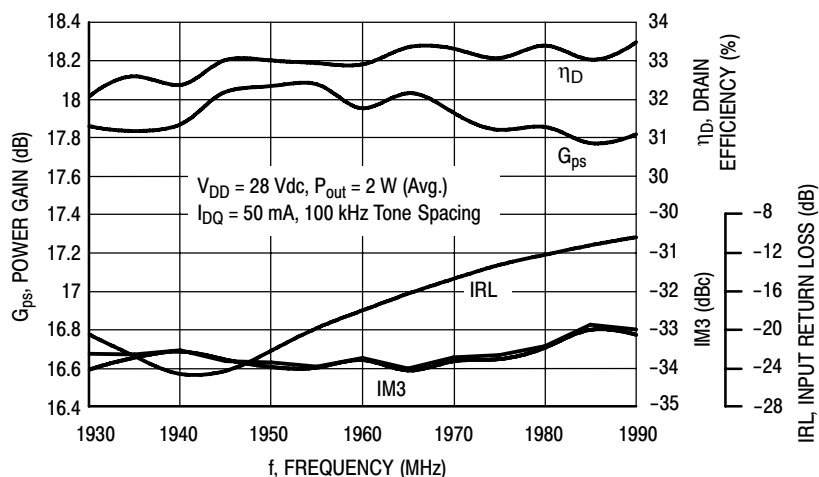


Figure 3. Two-Tone Wideband Performance @ P_{out} = 2 Watts Avg.

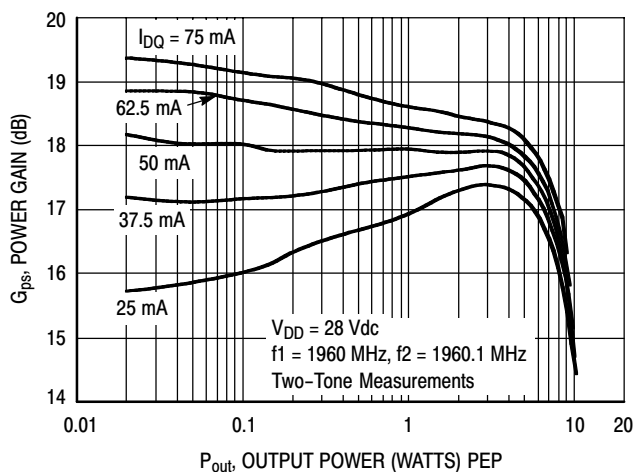


Figure 4. Two-Tone Power Gain versus Output Power

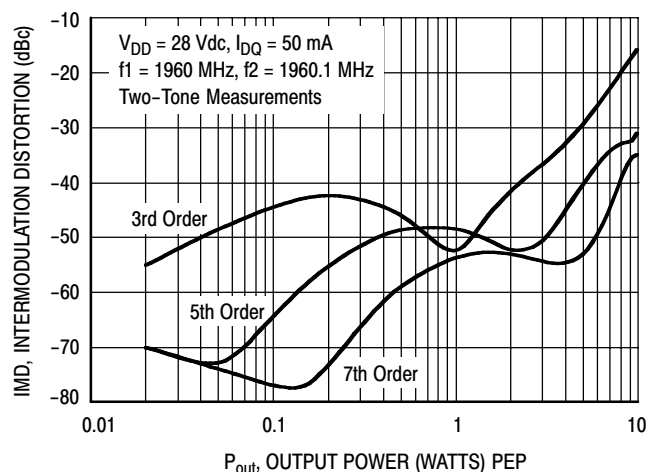


Figure 5. Intermodulation Distortion Products versus Output Power

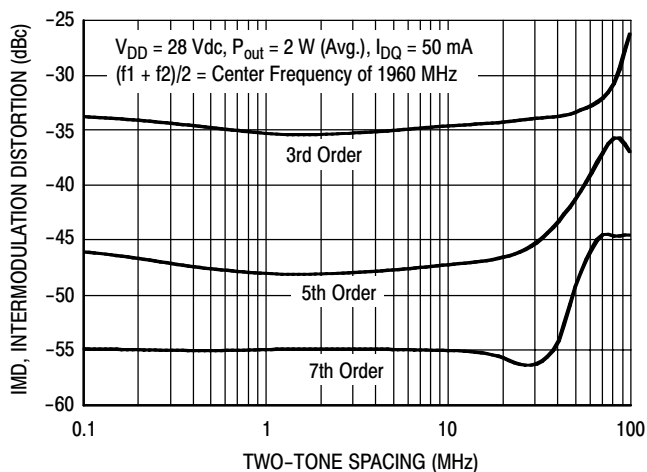


Figure 6. Intermodulation Distortion Products versus Tone Spacing

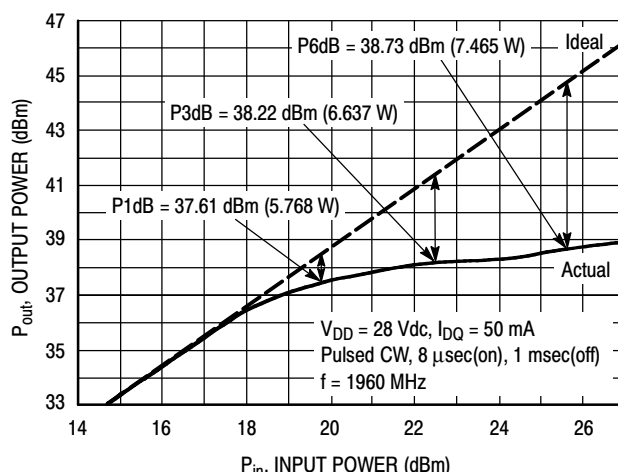


Figure 7. Pulsed CW Output Power versus Input Power

TYPICAL CHARACTERISTICS

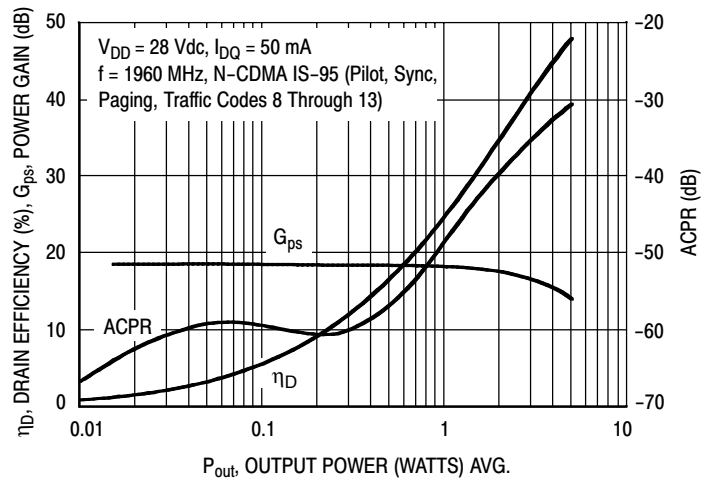


Figure 8. Single-Carrier CDMA ACPR, Power Gain and Drain Efficiency versus Output Power

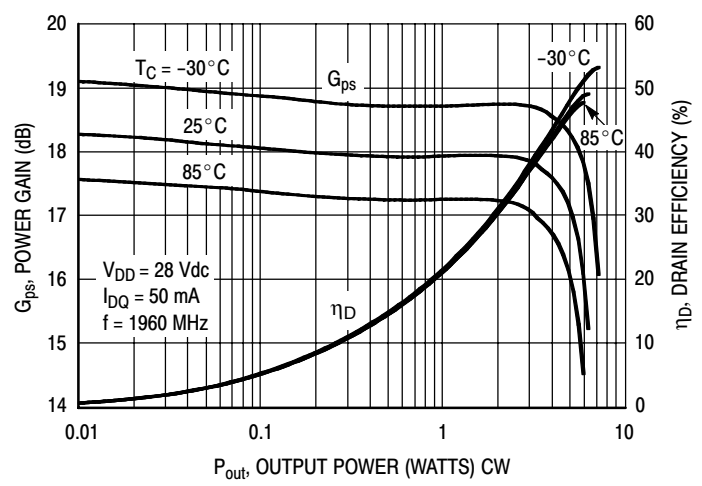


Figure 9. Power Gain and Drain Efficiency versus CW Output Power

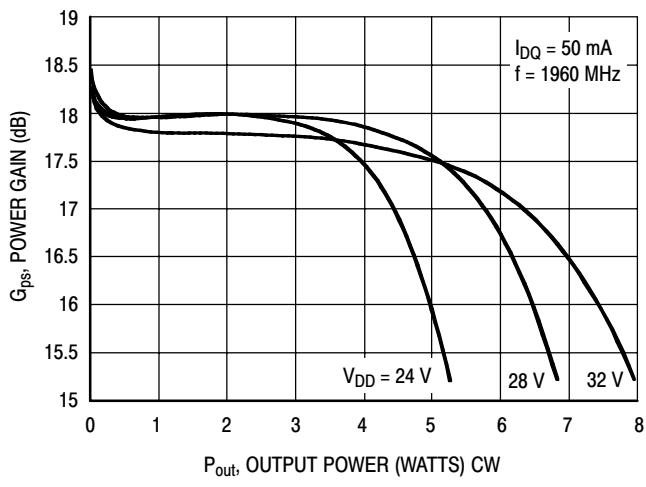


Figure 10. Power Gain versus Output Power

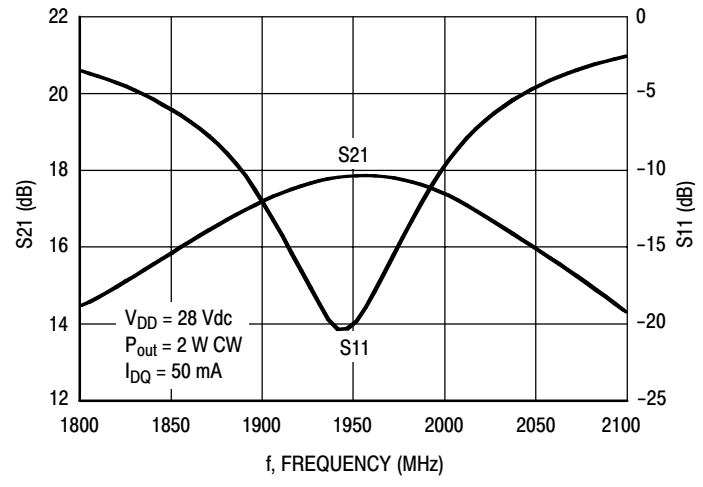
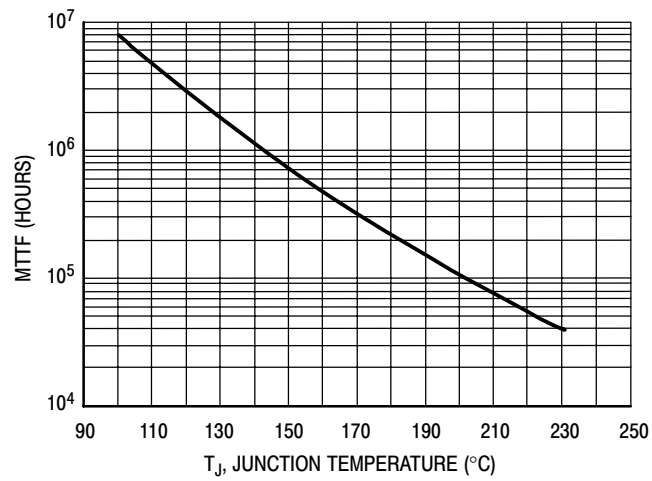


Figure 11. Broadband Frequency Response

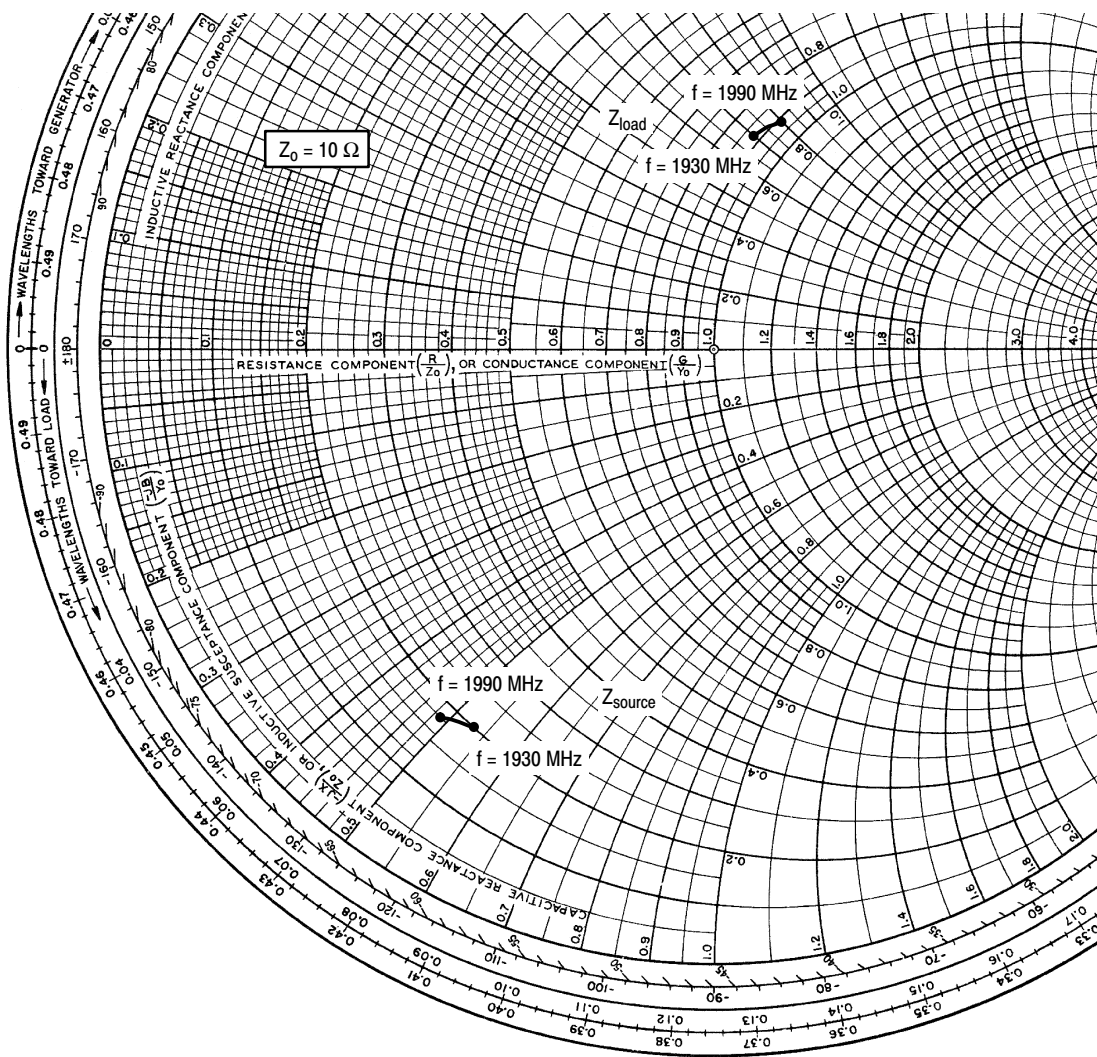
TYPICAL CHARACTERISTICS



This above graph displays calculated MTTF in hours when the device is operated at $V_{DD} = 28$ Vdc, $P_{out} = 4$ W PEP, and $\eta_D = 33\%$.

MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

Figure 12. MTTF versus Junction Temperature



$V_{DD} = 28 \text{ Vdc}$, $I_{DQ} = 50 \text{ mA}$, $P_{out} = 4 \text{ W PEP}$

| f MHz | Z _{source} Ω | Z _{load} Ω |
|----------|--------------------------|------------------------|
| 1930 | 1.96 - j5.34 | 8.78 + j6.96 |
| 1960 | 1.89 - j5.10 | 8.93 + j7.46 |
| 1990 | 1.82 - j4.85 | 9.11 + j7.97 |

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

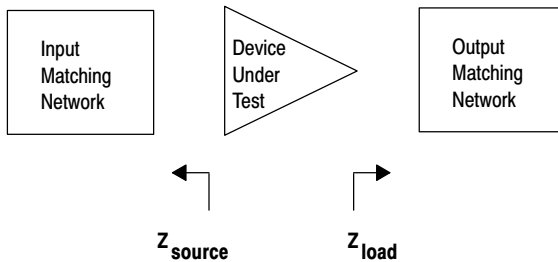


Figure 13. Series Equivalent Source and Load Impedance

Table 7. Common Source Scattering Parameters ($V_{DD} = 28\text{ V}$, 50 ohm system)

$I_{DQ} = 50\text{ mA}$

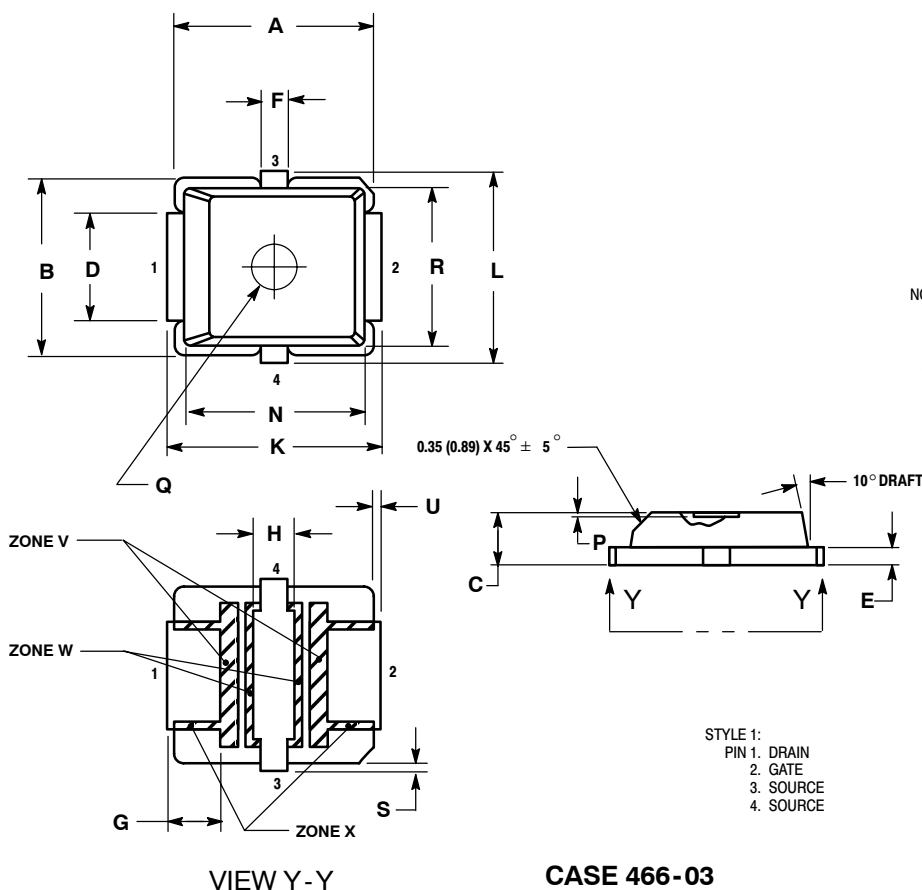
| f MHz | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | |
|----------|-----------------|----------|-----------------|---------|-----------------|----------|-----------------|----------|
| | S ₁₁ | ∠ φ | S ₂₁ | ∠ φ | S ₁₂ | ∠ φ | S ₂₂ | ∠ φ |
| 500 | 0.649 | -116.340 | 7.902 | 105.420 | 0.056 | -73.750 | 0.548 | -33.570 |
| 550 | 0.695 | -121.680 | 7.502 | 98.790 | 0.053 | -80.570 | 0.593 | -41.480 |
| 600 | 0.733 | -126.560 | 7.111 | 92.380 | 0.049 | -87.010 | 0.632 | -48.890 |
| 650 | 0.770 | -131.340 | 6.699 | 86.290 | 0.045 | -93.280 | 0.669 | -56.000 |
| 700 | 0.800 | -135.740 | 6.302 | 80.450 | 0.041 | -99.120 | 0.701 | -62.810 |
| 750 | 0.827 | -140.030 | 5.922 | 74.850 | 0.038 | -104.850 | 0.727 | -69.290 |
| 800 | 0.848 | -143.950 | 5.552 | 69.630 | 0.035 | -110.110 | 0.750 | -75.350 |
| 850 | 0.866 | -147.690 | 5.220 | 64.580 | 0.032 | -115.220 | 0.770 | -81.130 |
| 900 | 0.882 | -151.140 | 4.891 | 59.970 | 0.029 | -119.960 | 0.786 | -86.570 |
| 950 | 0.895 | -154.560 | 4.597 | 55.490 | 0.026 | -124.790 | 0.800 | -91.730 |
| 1000 | 0.907 | -157.590 | 4.315 | 51.240 | 0.024 | -129.090 | 0.813 | -96.660 |
| 1050 | 0.916 | -160.540 | 4.060 | 47.170 | 0.022 | -133.370 | 0.824 | -101.340 |
| 1100 | 0.923 | -163.310 | 3.819 | 43.340 | 0.020 | -137.460 | 0.833 | -105.790 |
| 1150 | 0.929 | -165.930 | 3.601 | 39.650 | 0.018 | -141.440 | 0.840 | -110.050 |
| 1200 | 0.935 | -168.430 | 3.398 | 36.110 | 0.017 | -145.330 | 0.847 | -114.170 |
| 1250 | 0.938 | -170.770 | 3.210 | 32.740 | 0.015 | -149.540 | 0.851 | -118.060 |
| 1300 | 0.942 | -173.030 | 3.036 | 29.490 | 0.014 | -153.430 | 0.856 | -121.880 |
| 1350 | 0.945 | -175.140 | 2.875 | 26.360 | 0.013 | -157.460 | 0.859 | -125.520 |
| 1400 | 0.948 | -177.170 | 2.728 | 23.330 | 0.012 | -161.910 | 0.863 | -129.020 |
| 1450 | 0.951 | -179.090 | 2.590 | 20.440 | 0.011 | -166.180 | 0.866 | -132.390 |
| 1500 | 0.953 | 179.030 | 2.464 | 17.640 | 0.010 | -170.630 | 0.869 | -135.650 |
| 1550 | 0.954 | 177.270 | 2.347 | 14.920 | 0.009 | -174.890 | 0.872 | -138.760 |
| 1600 | 0.955 | 175.570 | 2.240 | 12.320 | 0.008 | 179.950 | 0.875 | -141.750 |
| 1650 | 0.956 | 173.980 | 2.139 | 9.740 | 0.008 | 173.920 | 0.877 | -144.650 |
| 1700 | 0.957 | 172.350 | 2.047 | 7.250 | 0.007 | 167.710 | 0.880 | -147.480 |
| 1750 | 0.957 | 170.800 | 1.958 | 4.810 | 0.007 | 161.810 | 0.882 | -150.180 |
| 1800 | 0.958 | 169.340 | 1.879 | 2.440 | 0.006 | 155.370 | 0.884 | -152.760 |
| 1850 | 0.959 | 167.920 | 1.806 | 0.260 | 0.006 | 148.940 | 0.886 | -155.230 |
| 1900 | 0.959 | 166.510 | 1.736 | -1.980 | 0.005 | 142.630 | 0.887 | -157.580 |
| 1950 | 0.960 | 165.200 | 1.668 | -4.310 | 0.005 | 136.740 | 0.888 | -160.050 |
| 2000 | 0.959 | 163.800 | 1.611 | -6.240 | 0.005 | 129.910 | 0.890 | -162.070 |
| 2050 | 0.959 | 162.420 | 1.555 | -8.290 | 0.005 | 123.810 | 0.891 | -164.190 |
| 2100 | 0.958 | 161.170 | 1.504 | -10.270 | 0.005 | 118.200 | 0.892 | -166.140 |
| 2150 | 0.958 | 159.840 | 1.456 | -12.210 | 0.005 | 112.740 | 0.893 | -168.060 |
| 2200 | 0.957 | 158.560 | 1.412 | -14.130 | 0.005 | 108.460 | 0.894 | -169.840 |
| 2250 | 0.957 | 157.160 | 1.372 | -16.010 | 0.005 | 103.840 | 0.896 | -171.610 |
| 2300 | 0.955 | 155.870 | 1.334 | -17.870 | 0.005 | 99.310 | 0.896 | -173.260 |
| 2350 | 0.954 | 154.510 | 1.300 | -19.700 | 0.005 | 95.360 | 0.897 | -174.830 |
| 2400 | 0.953 | 153.120 | 1.268 | -21.510 | 0.005 | 91.030 | 0.898 | -176.390 |
| 2450 | 0.953 | 151.730 | 1.238 | -23.250 | 0.005 | 87.460 | 0.899 | -177.840 |

Table 7. Common Source Scattering Parameters ($V_{DD} = 28\text{ V}$, 50 ohm system) (continued)

$I_{DQ} = 50\text{ mA}$

| f MHz | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | |
|----------|-----------------|---------|-----------------|---------|-----------------|--------|-----------------|----------|
| | S ₁₁ | ∠ φ | S ₂₁ | ∠ φ | S ₁₂ | ∠ φ | S ₂₂ | ∠ φ |
| 2500 | 0.952 | 150.340 | 1.211 | -25.120 | 0.006 | 84.160 | 0.899 | -179.270 |
| 2550 | 0.950 | 149.010 | 1.187 | -26.920 | 0.006 | 80.780 | 0.897 | 179.420 |
| 2600 | 0.949 | 147.380 | 1.166 | -28.650 | 0.006 | 77.880 | 0.897 | 178.120 |
| 2650 | 0.948 | 145.920 | 1.144 | -30.420 | 0.007 | 74.670 | 0.898 | 176.840 |
| 2700 | 0.944 | 144.200 | 1.121 | -32.310 | 0.007 | 71.360 | 0.896 | 175.480 |
| 2750 | 0.944 | 142.790 | 1.105 | -34.230 | 0.007 | 67.980 | 0.897 | 174.060 |
| 2800 | 0.943 | 141.020 | 1.088 | -36.000 | 0.007 | 63.950 | 0.897 | 172.930 |
| 2850 | 0.941 | 139.410 | 1.073 | -37.870 | 0.007 | 61.230 | 0.896 | 171.630 |
| 2900 | 0.940 | 137.640 | 1.058 | -39.760 | 0.008 | 59.810 | 0.896 | 170.330 |
| 2950 | 0.938 | 135.900 | 1.045 | -41.680 | 0.008 | 58.280 | 0.896 | 169.040 |
| 3000 | 0.937 | 133.860 | 1.032 | -43.610 | 0.008 | 56.740 | 0.895 | 167.510 |

PACKAGE DIMENSIONS



- NOTES:
1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1984.
 2. CONTROLLING DIMENSION: INCH
 3. RESIN BLEED/FLASH ALLOWABLE IN ZONE V, W, AND X.

| DIM | INCHES | | MILLIMETERS | |
|--------|--------|-------|-------------|------|
| | MIN | MAX | MIN | MAX |
| A | 0.255 | 0.265 | 6.48 | 6.73 |
| B | 0.225 | 0.235 | 5.72 | 5.97 |
| C | 0.065 | 0.072 | 1.65 | 1.83 |
| D | 0.130 | 0.150 | 3.30 | 3.81 |
| E | 0.021 | 0.026 | 0.53 | 0.66 |
| F | 0.026 | 0.044 | 0.66 | 1.12 |
| G | 0.050 | 0.070 | 1.27 | 1.78 |
| H | 0.045 | 0.063 | 1.14 | 1.60 |
| J | 0.160 | 0.180 | 4.06 | 4.57 |
| K | 0.273 | 0.285 | 6.93 | 7.24 |
| L | 0.245 | 0.255 | 6.22 | 6.48 |
| N | 0.230 | 0.240 | 5.84 | 6.10 |
| P | 0.000 | 0.008 | 0.00 | 0.20 |
| Q | 0.055 | 0.063 | 1.40 | 1.60 |
| R | 0.200 | 0.210 | 5.08 | 5.33 |
| S | 0.006 | 0.012 | 0.15 | 0.31 |
| U | 0.006 | 0.012 | 0.15 | 0.31 |
| ZONE V | 0.000 | 0.021 | 0.00 | 0.53 |
| ZONE W | 0.000 | 0.010 | 0.00 | 0.25 |
| ZONE X | 0.000 | 0.010 | 0.00 | 0.25 |

**CASE 466-03
 ISSUE D
 PLD 1.5
 PLASTIC**

Refer to the following documents to aid your design process.

Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- RF High Power Model

For Software and Tools, do a Part Number search at <http://www.freescale.com>, and select the “Part Number” link. Go to the Software & Tools tab on the part’s Product Summary page to download the respective tool.

REVISION HISTORY

The following table summarizes revisions to this document.

| Revision | Date | Description |
|----------|-----------|---|
| 2 | Feb. 2007 | <ul style="list-style-type: none"> • Corrected MSL Rating from 3 to 1 in Table 4, Moisture Sensitivity Level, p. 2 • Updated $V_{GS(th)}$ and $V_{GS(Q)}$ to reflect tighter HV6 windows and added Fixture Gate Quiescent $V_{GG(Q)}$ to On Characteristics table to account for test fixture resistor divider network, p. 2 • Updated Part Numbers in Table 6, Component Designations and Values, to RoHS compliant part numbers, p. 3 • Removed lower voltage tests from Fig. 10, Power Gain versus Output Power, due to fixed tuned fixture limitations, p. 6 • Replaced Figure 12, MTTF versus Junction Temperature with updated graph. Removed Amps² and listed operating characteristics and location of MTTF calculator for device, p. 7 • Added Product Documentation and Revision History section, p. 12 |
| 3 | Apr. 2009 | <ul style="list-style-type: none"> • Corrected ESD structures to reflect current testing results. Changed HBM from 1A to 1C and CDM from III to IV, p. 1 • Corrected C_{iss} test condition to indicate AC stimulus on the V_{GS} connection versus the V_{DS} connection, Dynamic Characteristics table, p. 2 • Updated PCB information to show more specific material details, Fig. 1, Test Circuit Schematic, p. 3 • Updated Part Numbers in Table 6, Component Designations and Values, to latest RoHS compliant part numbers, p. 3 |
| 4 | June 2009 | <ul style="list-style-type: none"> • Modified data sheet to reflect MSL rating change from 1 to 3 as a result of the standardization of packing process as described in Product and Process Change Notification number, PCN13516, p. 2 • Added Electromigration MTTF Calculator and RF High Power Model availability to Product Documentation, Tools and Software, p. 12 |

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